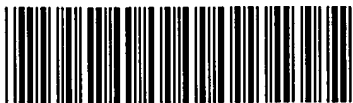


Search Notes

Application/Control No.

10/699,918

Examiner

Dru M. Parries

Applicant(s)/Patent under
Reexamination

CERN, YEHUDA

Art Unit

2836

SEARCHED

Class	Subclass	Date	Examiner
307	89	2/14/2006	DMP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search notes attached (REVISED)	7/5/2006	DMP
Received search help from STIC	6/30/2006	DMP